

<b>Notice of References Cited</b>	Application/Control No. 10/706,381		Applicant(s)/Patent Under Reexamination DOVEK ET AL.	
	Examiner Matthew G. Kayrish		Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,530,141	03-2003	Komuro et al.	29/603.14
*	B	US-5,850,326	12-1998	Takano et al.	360/122
*	C	US-2003/0151849	08-2003	Sasaki et al.	360/123
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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